Power MOSFET

30 V, 2.5 A, Single N-Channel, SOT-23

Features

- Leading Planar Technology for Low Gate Charge / Fast Switching
- 4.5 V Rated for Low Voltage Gate Drive
- SOT-23 Surface Mount for Small Footprint (3 x 3 mm)
- AEC Q101 Qualified NVTR4503N
- These Devices are Pb-Free and are RoHS Compliant

Applications

- DC–DC Conversion
- Load/Power Switch for Portables
- Load/Power Switch for Computing

MAXIMUM RATINGS (T_J = $25^{\circ}C$ unless otherwise noted)

Parame	Symbol	Value	Unit		
Drain-to-Source Voltage			V _{DSS}	30	V
Gate-to-Source Voltage			V _{GS}	±20	V
Continuous Drain	Steady	T _A = 25°C	I _D	2.0	А
Current (Note 1)	State	$T_A = 85^{\circ}C$		1.5	
	$t \le 10 s$	$T_A = 25^{\circ}C$		2.5	
Power Dissipation (Note 1)	$\begin{array}{c} \text{Steady} \\ \text{State} \end{array} T_{\text{A}} = 25^{\circ}\text{C}$		P _D	0.73	W
Continuous Drain	Steady State	$T_A = 25^{\circ}C$	Ι _D	1.5	А
Current (Note 2)		T _A = 85°C		1.1	
Power Dissipation (Note 2)		$T_A = 25^{\circ}C$	PD	0.42	W
Pulsed Drain Current	t _p =	= 10 μs	I _{DM}	10	А
$\begin{array}{c c} \mbox{ESD Capability (Note 3)} & \mbox{C} = 100 \ \mbox{pF}, \\ \mbox{RS} = 1500 \ \mbox{\Omega} \end{array}$			ESD	125	V
Operating Junction and S	T _J , T _{stg}	–55 to 150	°C		
Source Current (Body Dio	I _S	2.0	А		
Lead Temperature for Sol (1/8" from case for 10 s)	TL	260	°C		

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

THERMAL RESISTANCE RATINGS

Parameter	Symbol	Max	Unit
Junction-to-Ambient - Steady State (Note 1)	$R_{\theta JA}$	170	°C/W
Junction-to-Ambient - t < 10 s (Note 1)	$R_{\theta JA}$	100	
Junction-to-Ambient - Steady State (Note 2)	$R_{\theta JA}$	300	

1. Surface-mounted on FR4 board using 1 in sq pad size.

2. Surface-mounted on FR4 board using the minimum recommended pad size.

3. ESD Rating Information: HBM Class 0.

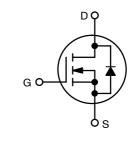


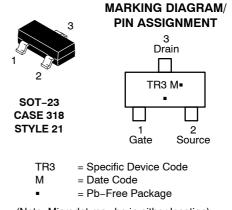
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V _{(BR)DSS}	V _{(BR)DSS} R _{DS(on)} TYP	
30 V	85 mΩ @ 10 V	2.5 A
00 1	105 m Ω @ 4.5 V	







(Note: Microdot may be in either location)

ORDERING INFORMATION

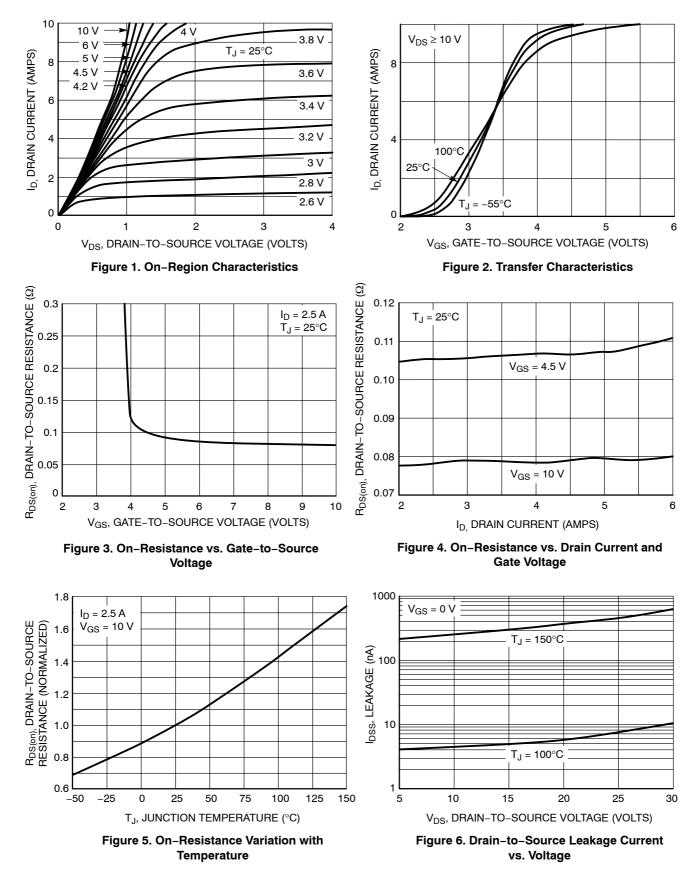
	Device	Package	Shipping [†]
N	TR4503NT1G	SOT-23 (Pb-Free)	3000 / Tape & Reel
N	VTR4503NT1G	SOT-23 (Pb-Free)	3000 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

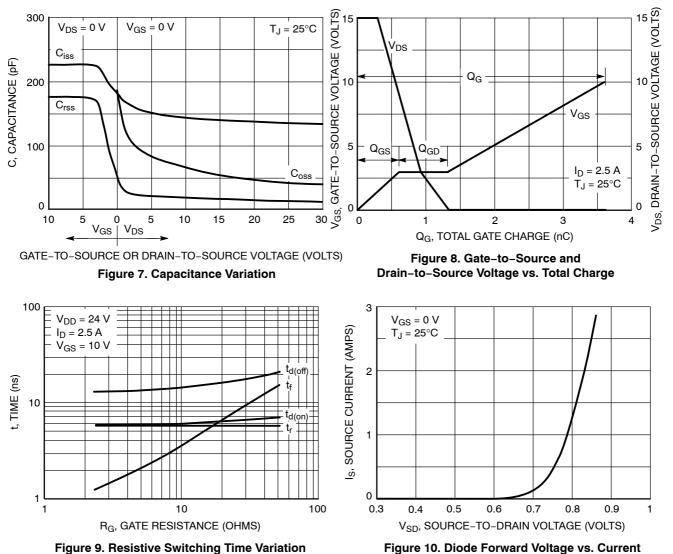
ELECTRICAL CHARACTERISTICS (T_J = 25° C unless otherwise noted)

Parameter	Parameter Symbol Test Conditions		Min	Тур	Max	Units
OFF CHARACTERISTICS	-	•	-	-		-
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	V_{GS} = 0 V, I _D = 250 μ A	30	36		V
Zero Gate Voltage Drain Current	I _{DSS}	V_{GS} = 0 V, V_{DS} = 24 V	$V_{GS} = 0 V, V_{DS} = 24 V$		1.0	μΑ
		V_{GS} = 0 V, V_{DS} = 24 V, T_J = 125°C			10	
Gate-to-Source Leakage Current	I _{GSS}	V_{DS} = 0 V, V_{GS} = ±20 V			±100	nA
ON CHARACTERISTICS (Note 4)						
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}$, $I_D = 250 \ \mu A$	1.0	1.75	3.0	V
Drain-to-Source On-Resistance	R _{DS(on)}	R _{DS(on)} V _{GS} = 10 V, I _D = 2.5 A		85	110	mΩ
		$V_{GS} = 4.5 \text{ V}, I_D = 2.0 \text{ A}$		105	140	
Forward Transconductance	9 FS	V _{DS} = 4.5 V, I _D = 2.5 A		5.3		S
CHARGES AND CAPACITANCES	•					
Input Capacitance	C _{iss}			135		pF
Output Capacitance	C _{oss}	V _{GS} = 0 V, f = 1.0 MHz, V _{DS} = 15 V		52		
Reverse Transfer Capacitance	C _{rss}	•DS - 13 •		15		
Input Capacitance	C _{iss}			130	250	pF
Output Capacitance	C _{oss}	V _{GS} = 0 V, f = 1.0 MHz, V _{DS} = 24 V		42	75	-
Reverse Transfer Capacitance	C _{rss}	• DS - 2+ •		13	25	
Total Gate Charge	Q _{G(TOT)}			3.6	7.0	nC
Threshold Gate Charge	Q _{G(TH)}	V _{GS} = 10 V, V _{DS} = 15 V,		0.3		
Gate-to-Source Charge	Q _{GS}	$I_{\rm D} = 2.5 \rm{A}$		0.6		
Gate-to-Drain Charge	Q _{GD}			0.7		
Total Gate Charge	Q _{G(TOT)}			1.9		nC
Threshold Gate Charge	Q _{G(TH)}	V _{GS} = 4.5 V, V _{DS} = 24 V,		0.3		1
Gate-to-Source Charge	Q _{GS}	I _D = 2.5 A		0.6		
Gate-to-Drain Charge	Q _{GD}			0.9		
SWITCHING CHARACTERISTICS (No	ote 5)	-				
Turn-On Delay Time	t _{d(on)}			5.8	12	ns
Rise Time	t _r	V _{GS} = 10 V, V _{DD} = 15 V,		5.8	10	
Turn-Off Delay Time	t _{d(off)}	$I_D = 1 \text{ A}, \text{ R}_G = 6 \Omega$		14	25	
Fall Time	t _f			1.6	5.0	
Turn-On Delay Time	t _{d(on)}			4.8		ns
Rise Time	t _r	V _{GS} = 10 V, V _{DD} = 24 V,		6.7		1
Turn-Off Delay Time	t _{d(off)}	$\begin{array}{l} V_{\mathrm{GS}} = 10 \text{ V}, V_{\mathrm{DD}} = 24 \text{ V}, \\ I_{\mathrm{D}} = 2.5 \text{ A}, R_{\mathrm{G}} = 2.5 \ \Omega \end{array}$		13.6		1
Fall Time	t _f			1.8		1
DRAIN-SOURCE DIODE CHARACTE	RISTICS					
Forward Diode Voltage	V _{SD}	$V_{GS} = 0 V, I_{S} = 2.0 A$		0.85	1.2	V
Reverse Recovery Time	t _{RR}	V _{GS} = 0 V, I _S = 2.0 A,		9.2		ns
Reverse Recovery Charge	Q _{RR}	dl _S /dt = 100 A/μs		4.0		nC

TYPICAL PERFORMANCE CURVES



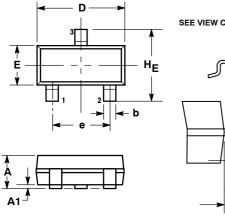
TYPICAL PERFORMANCE CURVES

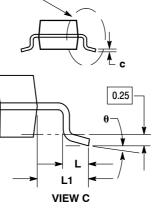


vs. Gate Resistance

PACKAGE DIMENSIONS

SOT-23 (TO-236) CASE 318-08 **ISSUE AP**





NOTES:

STYLE 21

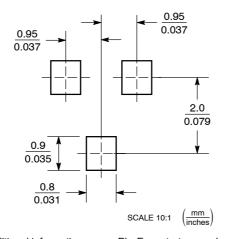
PIN 1. GATE SOURCE 2.

3

- 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982. CONTROLLING DIMENSION: INCH. MAXIMUM LEAD THICKNESS INCLUDES LEAD FINISH
- 3 THICKNESS. MINIMUM LEAD THICKNESS IS THE MINIMUM THICKNESS OF BASE MATERIAL.
- DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH, 4. PROTRUSIONS, OR GATE BURRS

	MILLIMETERS			INCHES		
DIM	MIN	NOM	MAX	MIN	NOM	MAX
Α	0.89	1.00	1.11	0.035	0.040	0.044
A1	0.01	0.06	0.10	0.001	0.002	0.004
b	0.37	0.44	0.50	0.015	0.018	0.020
с	0.09	0.13	0.18	0.003	0.005	0.007
D	2.80	2.90	3.04	0.110	0.114	0.120
E	1.20	1.30	1.40	0.047	0.051	0.055
е	1.78	1.90	2.04	0.070	0.075	0.081
L	0.10	0.20	0.30	0.004	0.008	0.012
L1	0.35	0.54	0.69	0.014	0.021	0.029
HE	2.10	2.40	2.64	0.083	0.094	0.104
θ	0°		10°	0°		10°

SOLDERING FOOTPRINT*



*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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